

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/682,432	TEPPER ET AL.		
Examiner	Art Unit		
Ling-Siu Choi	1796		

SEARCHED				
Class	Subclass	Date	Examiner	
526	328	1/4/2008	LSC ·	
	318			
	310			
521	61			
	63			
			:	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
West .	1/4/2008	LSC
particle, molecular imprint, propellant, supercritical, template, monomer		
class/subclass search		
inventor search .		